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Application/Control No.	Applicant(s)/Patent under Reexamination
10/766,858	KIM ET AL.
Examiner	Art Unit
Susan F. Rayyan	2167

SEARCHED			
Class	Subclass	Date	Examiner
707	3,102,104. 1	1/18/2006	SR
386	85	1/18/2006	SR
360	50	1/18/2006	SR

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
707	102	1/18/2006	SR	
707	104.1	1/18/2006	SR	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Updated East Search	1/18/2006	SR	
Inventor's name Search	1/18/2006	SR	
EIC serach	1/26/2006	SR	